

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

**TC74AC164P, TC74AC164F, TC74AC164FN, TC74AC164FT****8 - BIT SHIFT REGISTER (S - IN, P - OUT)**

The TC74AC164 is an advanced high speed CMOS 8 - BIT SERIAL - IN PARALLEL - OUT SHIFT REGISTER fabricated with silicon gate and double - layer metal wiring C2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It consists of a serial - in, parallel - out 8 - bit shift register with a CLOCK input and an overriding CLEAR input.

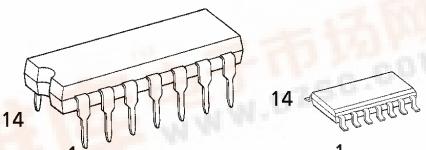
Two serial data inputs (A, B) are provided so that one may be used as a data enable.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

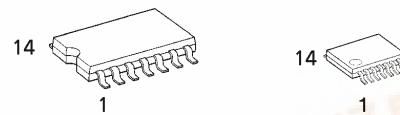
**FEATURES :**

- High Speed..... $f_{MAX} = 170\text{MHz}$  (typ.) at  $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 8\mu\text{A}$ (Max.) at  $T_a = 25^\circ\text{C}$
- High Noise Immunity..... $V_{NIH} = V_{NIL} = 28\%$   $V_{CC}$  (Min.)
- Symmetrical Output Impedance..... $|I_{OH}| = I_{OL} = 24\text{mA}$ (Min.)  
Capability of driving  $50\Omega$  transmission lines.
- Balanced Propagation Delays..... $t_{PLH} \approx t_{PHL}$
- Wide Operating Voltage Range..... $V_{CC}$  (opr) =  $2\text{V} \sim 5.5\text{V}$
- Pin and Function Compatible with 74F164

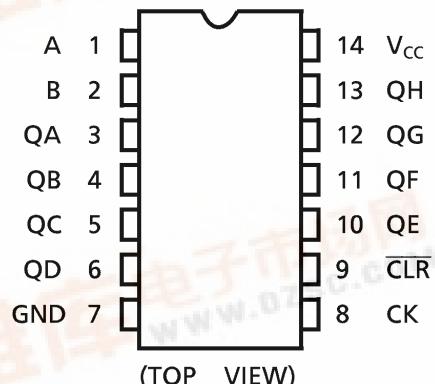
(Note) The JEDEC SOP (FN) is not available in Japan.



P (DIP14-P-300-2.54) FN (SOL14-P-150-1.27)  
Weight : 0.96g (Typ.) Weight : 0.12g (Typ.)

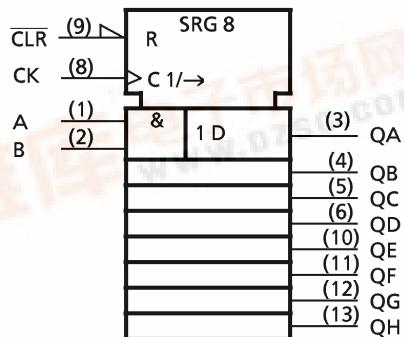


F (SOP14-P-300-1.27) FT (TSSOP14-P-0044-0.65)  
Weight : 0.18g (Typ.) Weight : 0.06g (Typ.)

**PIN ASSIGNMENT****TRUTH TABLE**

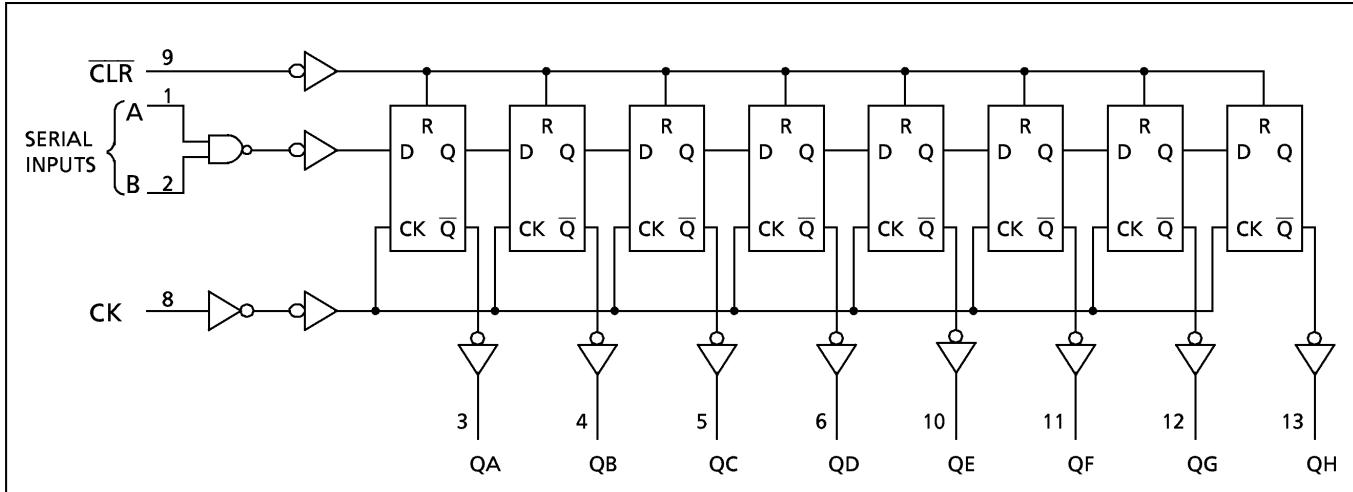
INPUTS			OUTPUTS				
CLR	CK	SERIAL IN		QA	QB	...	QH
		A	B				
L	X	X	X	L	L	...	L
H	—	X	X	NO CHANGE			
H	—	L	X	L	$QA_n$	...	$QG_n$
H	—	X	L	L	$QA_n$	...	$QG_n$
H	—	H	H	H	$QA_n$	...	$QG_n$

X : Don't Care

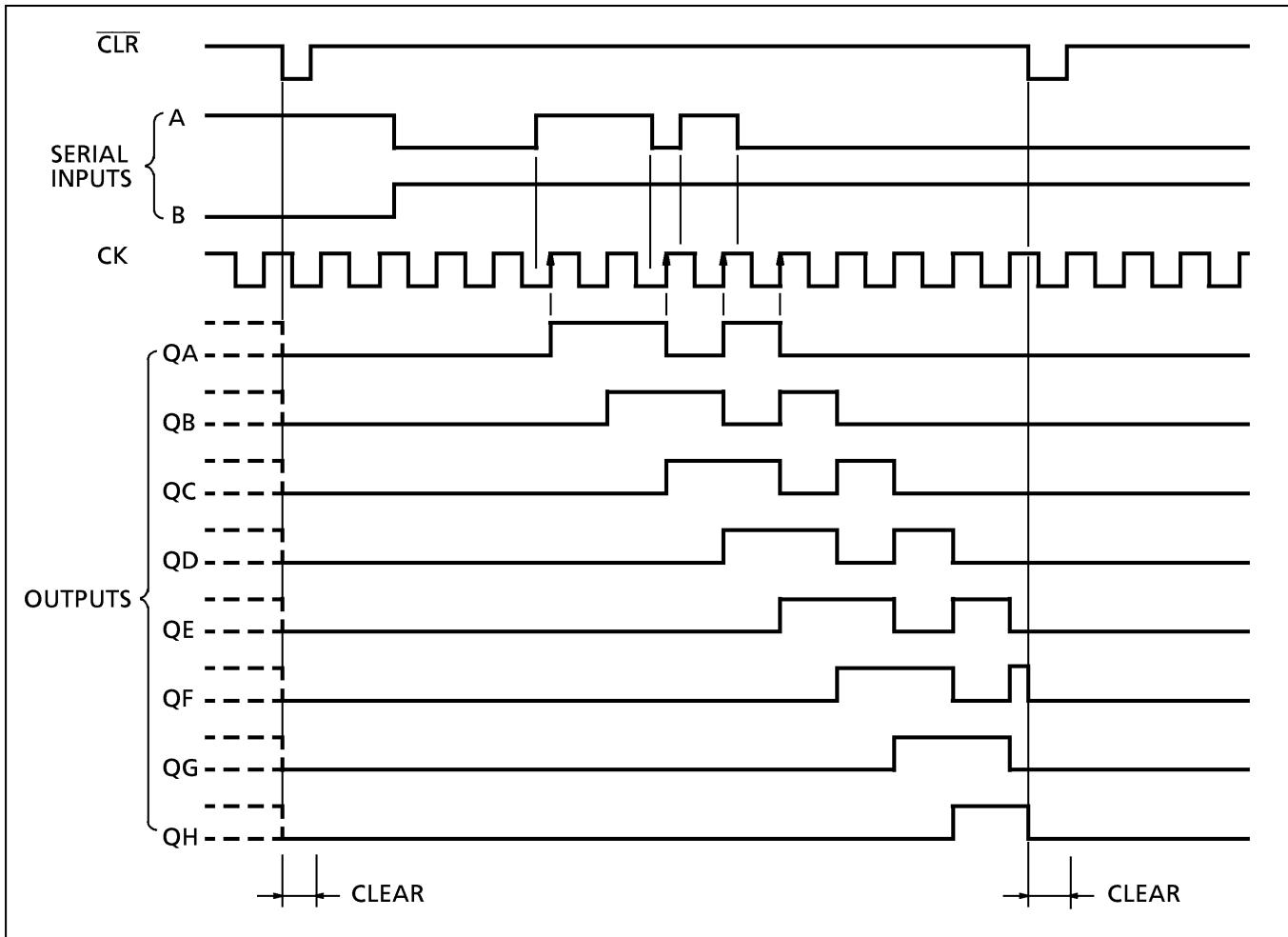
QA<sub>n</sub> ~ QG<sub>n</sub>: The level of QA ~ QG, respectively, before the most recent positive edge of the clock.**IEC LOGIC SYMBOL**

- TOSHIBA is continually working to improve the quality and the reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to observe standards of safety, and to avoid situations in which a malfunction or failure of a TOSHIBA product could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent products specifications. Also, please keep in mind the precautions and conditions set forth in the TOSHIBA Semiconductor Reliability Handbook.

## SYSTEM DIAGRAM



## TIMING CHART



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## ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	$V_{CC}$	-0.5~7.0	V
DC Input Voltage	$V_{IN}$	-0.5~ $V_{CC} + 0.5$	V
DC Output Voltage	$V_{OUT}$	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	$I_{IK}$	$\pm 20$	mA
Output Diode Current	$I_{OK}$	$\pm 50$	mA
DC Output Current	$I_{OUT}$	$\pm 50$	mA
DC $V_{CC}$ /Ground Current	$I_{CC}$	$\pm 200$	mA
Power Dissipation	$P_D$	500 (DIP)*/ 180 (SOP/TSSOP)	mW
Storage Temperature	$T_{STG}$	-65~150	°C

\*500mW in the range of  $T_a = -40^{\circ}\text{C} \sim 65^{\circ}\text{C}$ . From  $T_a = 65^{\circ}\text{C}$  to  $85^{\circ}\text{C}$  a derating factor of  $-10\text{mW}/^{\circ}\text{C}$  should be applied up to 300mW.

## RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	$V_{CC}$	2.0~5.5	V
Input Voltage	$V_{IN}$	0~ $V_{CC}$	V
Output Voltage	$V_{OUT}$	0~ $V_{CC}$	V
Operating Temperature	$T_{opr}$	-40~85	°C
Input Rise and Fall Time	$dt/dV$	0~ 100 ( $V_{CC} = 3.3 \pm 0.3\text{V}$ ) 0~ 20 ( $V_{CC} = 5 \pm 0.5\text{V}$ )	ns / V

## DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	Ta = 25°C			Ta = -40~85°C		UNIT
				MIN.	TYP.	MAX.	MIN.	MAX.	
High - Level Input Voltage	$V_{IH}$		2.0	1.50	—	—	1.50	—	V
			3.0	2.10	—	—	2.10	—	
			5.5	3.85	—	—	3.85	—	
Low - Level Input Voltage	$V_{IL}$		2.0	—	—	0.50	—	0.50	V
			3.0	—	—	0.90	—	0.90	
			5.5	—	—	1.65	—	1.65	
High - Level Output Voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -50\mu\text{A}$	2.0	1.9	2.0	—	1.9	V
				3.0	2.9	3.0	—	2.9	
				4.5	4.4	4.5	—	4.4	
			$I_{OH} = -4\text{mA}$ $I_{OH} = -24\text{mA}$ $I_{OH} = -75\text{mA}^*$	3.0	2.58	—	—	2.48	
Low - Level Output Voltage	$V_{OL}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 50\mu\text{A}$	4.5	3.94	—	—	3.80	V
				5.5	—	—	—	3.85	
			$I_{OL} = 12\text{mA}$ $I_{OL} = 24\text{mA}$ $I_{OL} = 75\text{mA}^*$	2.0	—	0.0	0.1	—	
				3.0	—	0.0	0.1	—	
Input Leakage Current	$I_{IN}$	$V_{IN} = V_{CC}$ or GND	4.5	—	—	0.0	0.1	—	$\mu\text{A}$
			5.5	—	—	—	—	—	
Quiescent Supply Current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND	5.5	—	—	8.0	—	80.0	

\* : This spec indicates the capability of driving  $50\Omega$  transmission lines.

One output should be tested at a time for a 10ms maximum duration.

TIMING REQUIREMENTS ( Input  $t_r = t_f = 3\text{ns}$  )

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C	Ta = -40~85°C	UNIT
			V <sub>CC</sub> (V)	LIMIT	
Minimum Pulse Width ( CK )	$t_W(L)$ $t_W(H)$		3.3 ± 0.3	9.0	ns
			5.0 ± 0.5	5.0	
	$t_W(L)$		3.3 ± 0.3	9.0	
			5.0 ± 0.5	5.0	
	$t_s$		3.3 ± 0.3	7.0	
			5.0 ± 0.5	4.0	
Minimum Hold Time	$t_h$		3.3 ± 0.3	1.0	ns
			5.0 ± 0.5	1.0	
Minimum Removal Time ( CLR )	$t_{rem}$		3.3 ± 0.3	8.5	ns
			5.0 ± 0.5	5.0	

AC ELECTRICAL CHARACTERISTICS ( C<sub>L</sub> = 50pF , R<sub>L</sub> = 500 Ω , Input  $t_r = t_f = 3\text{ns}$  )

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C		UNIT
			V <sub>CC</sub> (V)	MIN.	TYP.	MAX.	MIN.	
Propagation Delay Time ( CK-Q )	$t_{pLH}$ $t_{pHL}$		3.3 ± 0.3	—	9.6	16.3	1.0	ns
			5.0 ± 0.5	—	6.6	9.8	1.0	
Propagation Delay Time ( CLR-Q )	$t_{pHL}$		3.3 ± 0.3	—	8.0	15.4	1.0	ns
			5.0 ± 0.5	—	6.0	11.0	1.0	
Maximum Clock Frequency	f <sub>MAX</sub>		3.3 ± 0.3	45	100	—	45	—
			5.0 ± 0.5	80	150	—	80	—
Input Capacitance	C <sub>IN</sub>		—	5	10	—	10	pF
Power Dissipation Capacitance	C <sub>PD</sub> (1)		—	110	—	—	—	

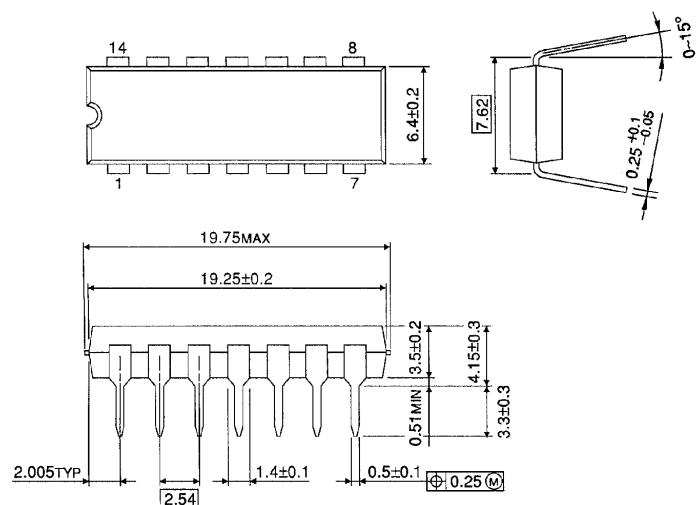
Note (1) C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

$$I_{CC}(\text{opr.}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

**DIP 14PIN OUTLINE DRAWING (DIP14-P-300-2.54)**

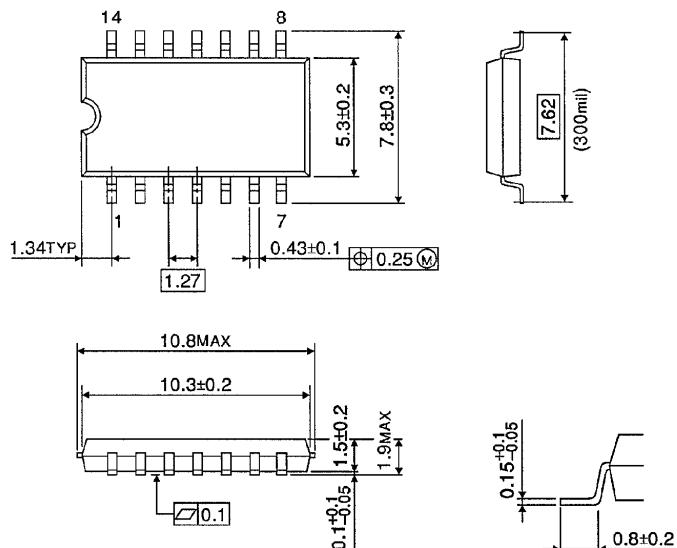
Unit in mm



Weight : 0.96g (Typ.)

**SOP 14PIN (200mil BODY) OUTLINE DRAWING (SOP14-P-300-1.27)**

Unit in mm

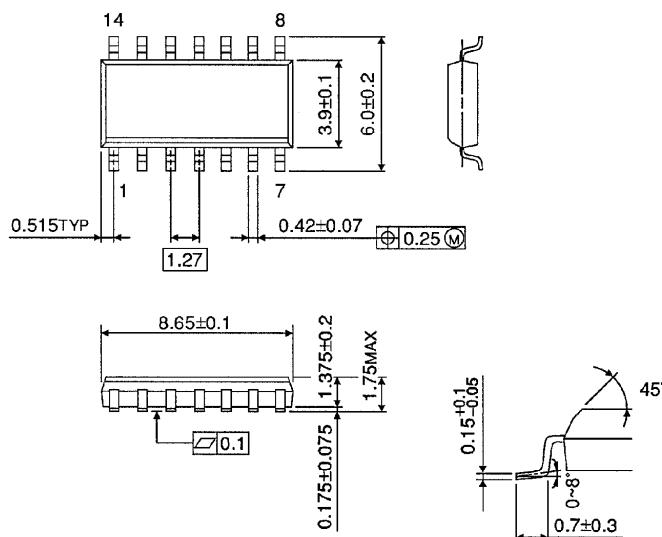


Weight : 0.18g (Typ.)

## SOP 14PIN (150mil BODY) OUTLINE DRAWING (SOL14-P-150 -1.27)

Unit in mm

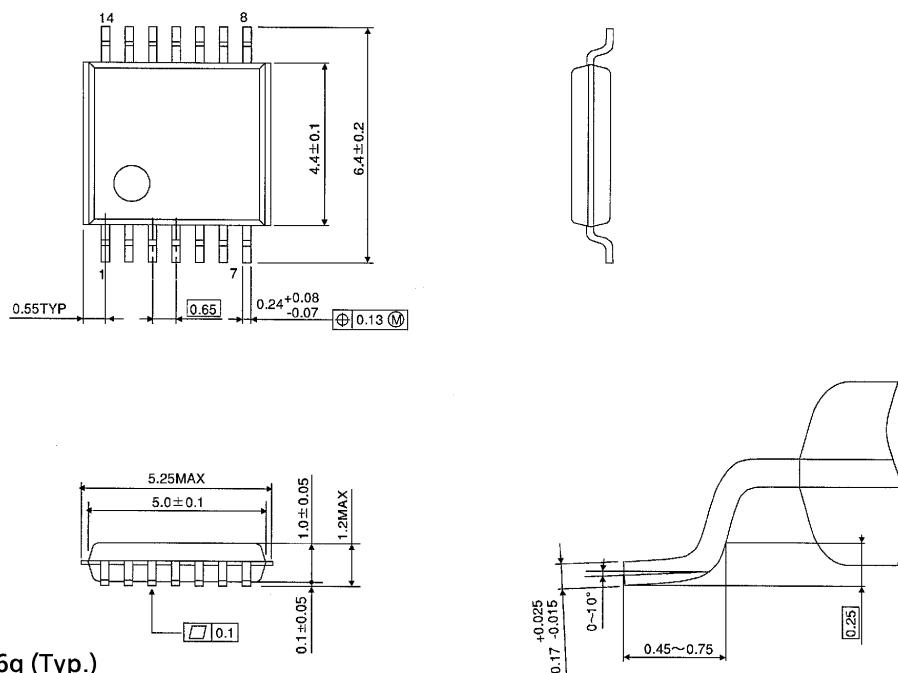
(Note) This package is not available in Japan.



Weight : 0.12g (Typ.)

## TSSOP 14PIN (170mil BODY) OUTLINE DRAWING (TSSOP14-P-0044-0.65)

Unit in mm



Weight : 0.06g (Typ.)